Title Of Invention: ELECTRONIC COMPONENT HANDLING APPARATUS AND ELECTRONIC COMPONENT TESTING APPARATUS

ABSTRACT

An electronic component handling apparatus capable of reducing the damage of the improvement and DUT operating rate is provide. A handler 30 that handles DUT 90 includes a sensor 51 and a moving device 52 that acquires three-dimensional shape data of the buffer plate 40 having a plurality of pockets 41 capable of accommodating DUT 90, a first correcting unit 61 that corrects the shape data by calculating a moving amount and/or a rotating amount in a plane direction from an initial state, an extraction unit 64 that extracts a height and/or a tilt of a predetermined area 91 corresponding to DUT 90 in the pocket 41 from the shape data corrected by the first correcting unit 61, and a determination unit 65 that determines an accommodation state of DUT 90 in the pocket 41 based on an extraction result of the extraction unit 64.

[FIG. 5]